

Notice of References Cited	Application/Control No. 10/748,512	Applicant(s)/Patent Under Reexamination MARCUS ET AL.	
	Examiner John E. Rovnak	Art Unit 3714	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-6,042,009	03-2000	Barrett et al.	235/441
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*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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